BALF-SPI-01D3



50 Ω nominal input / conjugate match balun to SPIRIT1, with integrated harmonic filter

Datasheet - production data

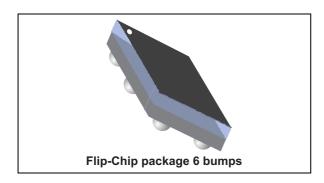


Figure 1. Pin coordinates (top view)

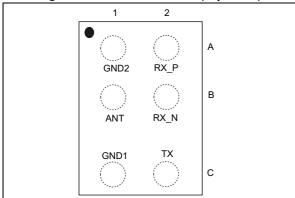
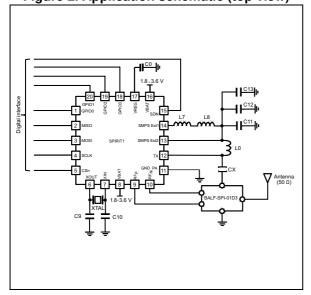


Figure 2. Application schematic (top view)



Features

- 50 Ω nominal input / conjugate match to SPIRIT1
- Low insertion loss
- Low amplitude imbalance
- Low phase imbalance
- · Small footprint

Benefits

- Very low profile (< 670 μm)
- High RF performance
- · RF BOM and area reduction

Applications

- 868 MHz and 915 MHz impedance matched balun filter
- Optimized for SPIRIT1 sub GHz RFIC

Description

STMicroelectronics BALF-SPI-01D3 is an ultra miniature balun. The BALF-SPI-01D3 integrates matching network and harmonics filters. Matching impedance has been customized for the SPIRIT1 ST transceiver.

The BALF-SPI-01D3 uses STMicroelectronics IPD technology on non-conductive glass substrate which optimize RF performance.

Characteristics BALF-SPI-01D3

1 Characteristics

Table 1. Absolute maximum ratings (limiting values)

Symbol	Parameter		Value		
			Тур.	Max.	Unit
P _{IN}	Input power RFIN		-	20	dBm
V _{ESD}	ESD ratings human body model (JESD22-A114-C), all I/O one at a time while others connected to GND		-		V
	ESD ratings machine model, all I/O	200	-		
T _{OP}	Operating temperature (JESD22-A115-C), all I/O	-40	-	+85	°C

Table 2. Impedances (T_{amb} = 25 °C)

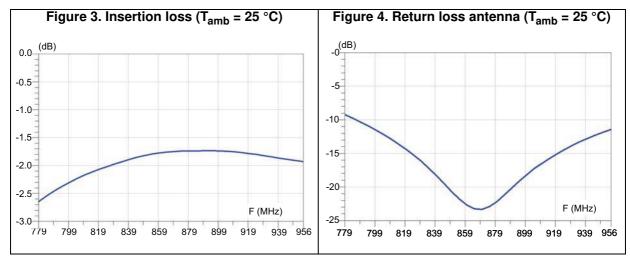
Cumbal	Parameter		Value			
Symbol	Parameter	Min.	Тур.	Max.	Unit	
Z _{RX}	Nominal differential RX balun impedance		match to SPIRIT1	_	Ω	
Z _{TX}	Nominal TX filter impedance		mater to Strikti i	-	22	
Z _{ANT}	Antenna impedance	-	50	-	Ω	

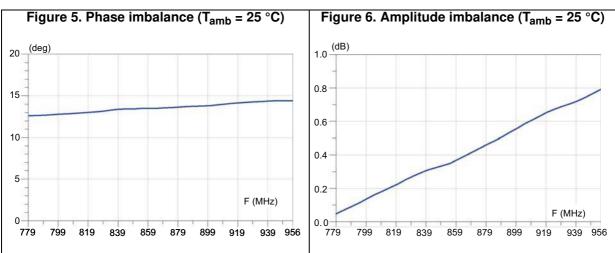
Table 3. RF performance (T_{amb} = 25 °C)

Cumbal	Parameter	Test condition	Value			Unit	
Symbol	Parameter	rest condition	Min.	Тур.	Max.	Oilit	
F	Frequency range (bandwidth)		779	868	956	MHz	
S21 _{RX-ANT}	Insertion loss in bandwidth without mismatch loss (RX balun)			-1.7	-2	dB	
S21 _{TX-ANT}	Insertion loss in bandwidth without mismatch loss (TX filter)			-1.4	-2	dB	
S11 _{ANT}	Input return loss in bandwidth (RX balun)			-23	-15	dB	
S11 _{ANT}	Input return loss in bandwidth (TX filter)			-15	-12	dB	
ϕ_{imb}	Output phase imbalance (RX balun)		5	10	15	0	
A _{imb}	Output amplitude imbalance (RX balun)			0.35	0.8	dB	
Att	Harmonic levels (TX filter)	Attenuation at 2fo		-35		dBm	
		Attenuation at 3fo		-40		GDIII	

BALF-SPI-01D3 Characteristics

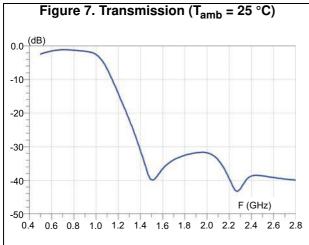
1.1 RF measurement (Rx balun)



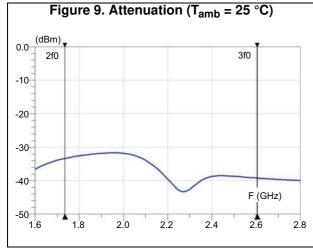


Characteristics BALF-SPI-01D3

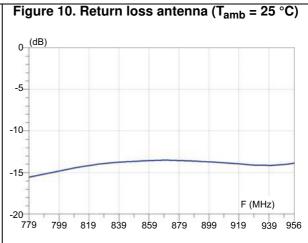
1.2 RF measurement (Tx filter)







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2 Application information

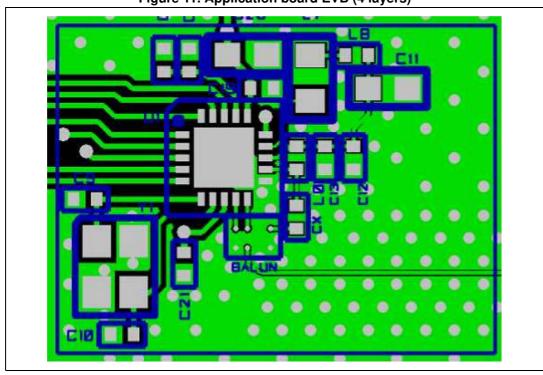
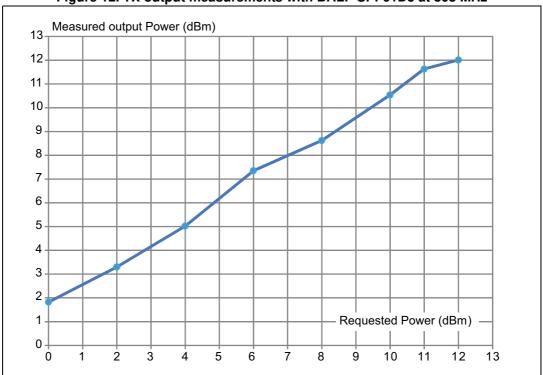


Figure 11. Application board EVB (4 layers)

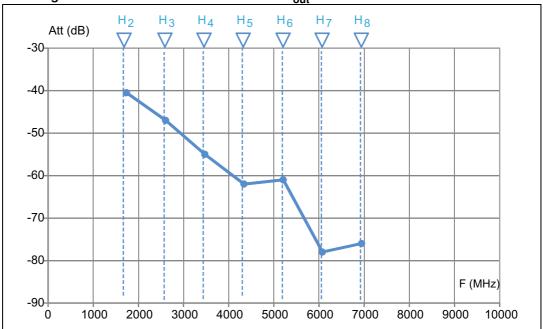




Measured output Power (dBm) i |i 915 -920 MHz 12 868 MHz 10 +10 dBm mode 8 6 2 0 0 dBm mode ⊭ (MHz) 800 820 840 860 880 900 920 940 960

Figure 13. TX output power measurements over frequency with BALF-SPI-01D3





BALF-SPI-01D3 Package information

3 Package information

- Epoxy meets UL94, V0
- Lead-free package

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: *www.st.com*. ECOPACK[®] is an ST trademark.

3.1 Flip-Chip package information

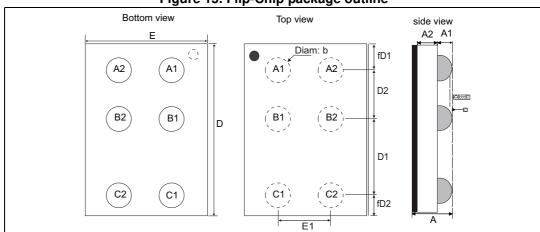


Figure 15. Flip-Chip package outline

Table 4. Flip-Chip package mechanical data

Parameter	Description	Min.	Тур.	Max.	Unit
Α	Bump height + substrate thickness	0.590	0.650	0.710	mm
A1	Bump height		0.200		mm
A2	Substrate thickness		0.400		mm
b	Bump diameter	0.210	0.250	0.290	mm
D	Y dimension of the die	1.950	2.000	1.950	mm
D1	Y pitch	0.960	1.000	1.040	mm
D2	Y pitch2	0.460	0.500	0.540	mm
Е	X dimension of the die	1.350	1.400	1.450	mm
E1	X pitch	0.790	0.820	0.850	mm
fD1	Distance from bump to edge of die on Y axis		0.295		mm
fD2	Distance from bump to edge of die on Y axis		0.195		mm
ccc				0.05	mm

Package information BALF-SPI-01D3

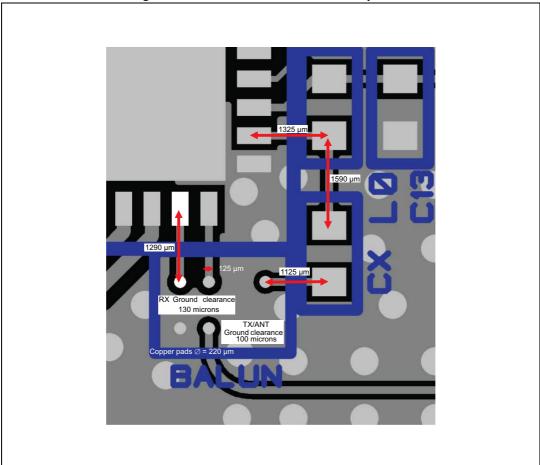
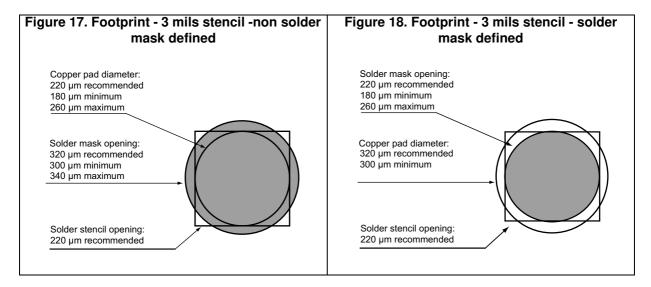
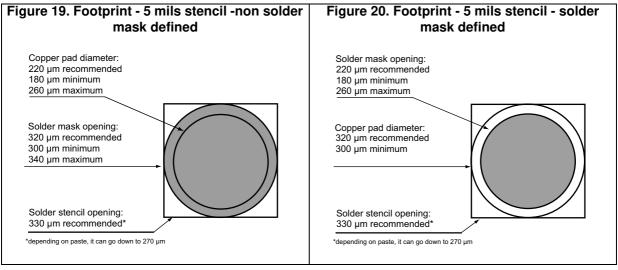


Figure 16. Recommended balun land pattern

BALF-SPI-01D3 Package information





Package information BALF-SPI-01D3

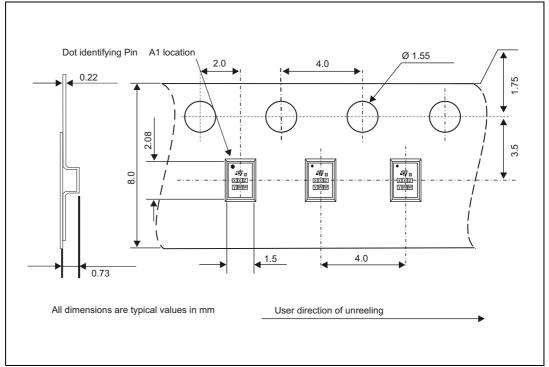
Figure 21. Marking

Dot, ST logo
ECOPACK grade
xx = marking
z = manufacturing
location
yww = datecode

XX X Z

Y W W

Figure 22. Flip Chip tape and reel specifications



Note: More information is available in the STMicroelectronics Application note: AN2348 Flip-Chip: "Package description and recommendations for use"

4 Ordering information

Table 5. Ordering information

Order code	Marking	Weight	Base Qty	Delivery mode
BALF-SPI-01D3	SJ	3.0 mg	5000	Tape and Reel

5 Revision history

Table 6. Document revision history

Date	Revision	Changes
27-Aug-2013	1	Initial release.
03-Oct-2013	2	Updated document title. Updated Table 1 with JESD22 references.
15-May-2015	3	Updated Figure 1 and Figure 15. Added Figure 19 and Figure 20.
18-Sep-2015	4	Updated Figure 15 and added Table 4.
17-Nov-2015	5	Updated Figure 2 and Figure 15.

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